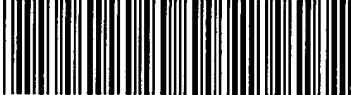


Issue Classification 	Application/Control No. 10/554,710	Applicant(s)/Patent under Reexamination YAMASAKI, TAKAHIRO
	Examiner Devin Hanan	Art Unit 3745

ISSUE CLASSIFICATION											
ORIGINAL				INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS		CLAIMED			NON-CLAIMED				
415		173.6		F	01	D	11 /02	/	/	/	/
CROSS REFERENCES								/	/	/	/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							/	/	/	/
415	206							/	/	/	/
								/	/	/	/
								/	/	/	/
								/	/	/	/
<i>Devin Hanan 3/7/07</i>	<i>JUSTINE R. YU 3/8/08</i>	Total Claims Allowed: 10									
Devin Hanan 3/7/2007 (Assistant Examiner) (Date)	JUSTINE R. YU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Primary Examiner) (Date)	O.G. Print Claim(s)					O.G. Print Fig.				
<i>K Cooper 3/13/07</i>	<i>3/13/07</i>	1					2				

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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25		55	85	115	145	175	205
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28		58	88	118	148	178	208
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30		60	90	120	150	180	210